

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10590791	HEUER ET AL.
	Examiner	Art Unit
	Quoc A Tran	2176

SEARCHED

Class	Subclass	Date	Examiner
715	234	8/28/2008	QT
715	235-250	8/28/2008	QT

SEARCH NOTES

Search Notes	Date	Examiner
NPL Search (ACM Digital Library)	8/28/2008	QT
EAST (USPAT, USPGPUB, JPO, USOCR, FPRS, EPO, DERWENT & IBM_TDB)	8/28/2008	QT
Inventors Searched Conducted- Considered Double Patent Rejection	8/28/2008	QT
Text Search Class 715/234-250	8/28/2008	QT

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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